

BLS6G3135-20; BLS6G3135S-20

LDMOS S-Band radar power transistor

Rev. 03 — 3 March 2009

Product data sheet

1. Product profile

1.1 General description

20 W LDMOS power transistor intended for radar applications in the 3.1 GHz to 3.5 GHz range.

Table 1. Typical performance

Typical RF performance at $T_{case} = 25\text{ }^{\circ}\text{C}$; $t_p = 300\text{ }\mu\text{s}$; $\delta = 10\%$; $I_{Dq} = 50\text{ mA}$; in a class-AB production test circuit.

| Mode of operation | f (GHz) | V _{DS} (V) | P _L (W) | G _p (dB) | η_D (%) | t _r (ns) | t _f (ns) |
|-------------------|------------|------------------------|-----------------------|------------------------|-----------------|------------------------|------------------------|
| Pulsed RF | 3.1 to 3.5 | 32 | 20 | 15.5 | 45 | 20 | 10 |

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features

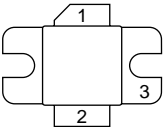
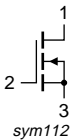
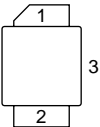
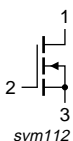
- Typical pulsed RF performance at a frequency of 3.1 GHz to 3.5 GHz, a supply voltage of 32 V, an I_{Dq} of 50 mA, a t_p of 300 μs and a δ of 10 %:
 - ◆ Output power = 20 W
 - ◆ Power gain = 15.5 dB
 - ◆ Efficiency = 45 %
- Integrated ESD protection
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (3.1 GHz to 3.5 GHz)
- Internally matched for ease of use
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

1.3 Applications

- S-Band power amplifiers for radar applications in the 3.1 GHz to 3.5 GHz frequency range

2. Pinning information

Table 2. Pinning

| Pin | Description | Simplified outline | Graphic symbol |
|--------------------------------|-------------|--|--|
| BLS6G3135-20 (SOT608A) | | | |
| 1 | drain |  |  sym112 |
| 2 | gate | | |
| 3 | source | | |
| BLS6G3135S-20 (SOT608B) | | | |
| 1 | drain |  |  sym112 |
| 2 | gate | | |
| 3 | source | | |

[1] Connected to flange.

3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|---------------|---------|--|---------|
| | Name | Description | Version |
| BLS6G3135-20 | - | flanged ceramic package; 2 mounting holes; 2 leads | SOT608A |
| BLS6G3135S-20 | - | ceramic earless flanged package; 2 leads | SOT608B |

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-----------|----------------------|------------|------|------|------|
| V_{DS} | drain-source voltage | | - | 60 | V |
| V_{GS} | gate-source voltage | | -0.5 | +13 | V |
| I_D | drain current | | - | 2.1 | A |
| T_{stg} | storage temperature | | -65 | +150 | °C |
| T_j | junction temperature | | - | 225 | °C |

5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions | Typ | Max | Unit |
|------------------|--|---|------|------|------|
| $R_{th(j-case)}$ | thermal resistance from junction to case | $T_{case} = 80\text{ °C}; P_L = 20\text{ W}$ | | | |
| | | $t_p = 100\text{ }\mu\text{s}; \delta = 20\text{ }\%$ | 0.76 | 0.92 | K/W |
| | | $t_p = 300\text{ }\mu\text{s}; \delta = 10\text{ }\%$ | 0.79 | 0.95 | K/W |

6. Characteristics

Table 6. Characteristics

$T_j = 25\text{ °C}$ unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---------------|----------------------------------|---|-----|------|------|---------------|
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $V_{GS} = 0\text{ V}; I_D = 0.5\text{ mA}$ | 60 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $V_{DS} = 10\text{ V}; I_D = 40\text{ mA}$ | 1.4 | 2 | 2.4 | V |
| I_{DSS} | drain leakage current | $V_{GS} = 0\text{ V}; V_{DS} = 28\text{ V}$ | - | - | 1.5 | μA |
| I_{DSX} | drain cut-off current | $V_{GS} = V_{GS(th)} + 3.75\text{ V}; V_{DS} = 10\text{ V}$ | 6 | 8.2 | - | A |
| I_{GSS} | gate leakage current | $V_{GS} = 8.3\text{ V}; V_{DS} = 0\text{ V}$ | - | - | 150 | nA |
| g_{fs} | forward transconductance | $V_{DS} = 10\text{ V}; I_D = 1.4\text{ A}$ | - | 2.8 | - | S |
| $R_{DS(on)}$ | drain-source on-state resistance | $V_{GS} = V_{GS(th)} + 3.75\text{ V}; I_D = 1.4\text{ A}$ | - | 0.37 | 0.58 | Ω |

7. Application information

Table 7. Application information

Mode of operation: pulsed RF; $t_p = 300\text{ }\mu\text{s}; \delta = 10\text{ }\%$; RF performance at $V_{DS} = 32\text{ V}; I_{Dq} = 50\text{ mA}; T_{case} = 25\text{ °C}$; unless otherwise specified; in a class-AB production circuit.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|----------|------------------|---------------------|-----|------|-----|------|
| P_L | output power | | - | 20 | - | W |
| V_{CC} | supply voltage | $P_L = 20\text{ W}$ | - | - | 32 | V |
| G_p | power gain | $P_L = 20\text{ W}$ | 12 | 15.5 | - | dB |
| η_D | drain efficiency | $P_L = 20\text{ W}$ | 40 | 45 | - | % |
| t_r | rise time | $P_L = 20\text{ W}$ | - | 20 | 50 | ns |
| t_f | fall time | $P_L = 20\text{ W}$ | - | 10 | 50 | ns |

7.1 Impedance information

Table 8. Typical impedance

| f GHz | Z _S Ω | Z _L (optimized for η _D) Ω | Z _L (optimized for G _p) Ω | G _{p(opt)} dB | η _D [1] % |
|----------|---------------------|---|---|---------------------------|-------------------------|
| 3.1 | 31.24 – j31.07 | 6.99 + j12.9 | 13.01 + j14.75 | 18.08 | 48.34 |
| 3.2 | 50.56 – j12.48 | 5.82 + j8.77 | 11.47 + j11.17 | 17.97 | 45.60 |
| 3.3 | 43.66 + j17.27 | 2.32 + j6.17 | 10.05 + j10.55 | 17.75 | 47.01 |
| 3.4 | 24.13 + j28.47 | 5.52 + j6.10 | 9.93 + j8.48 | 17.91 | 47.03 |
| 3.5 | 10.56 + j22.21 | 5.79 + j3.19 | 9.37 + j5.73 | 17.68 | 46.54 |

[1] Measured with Z_L optimized for G_p.

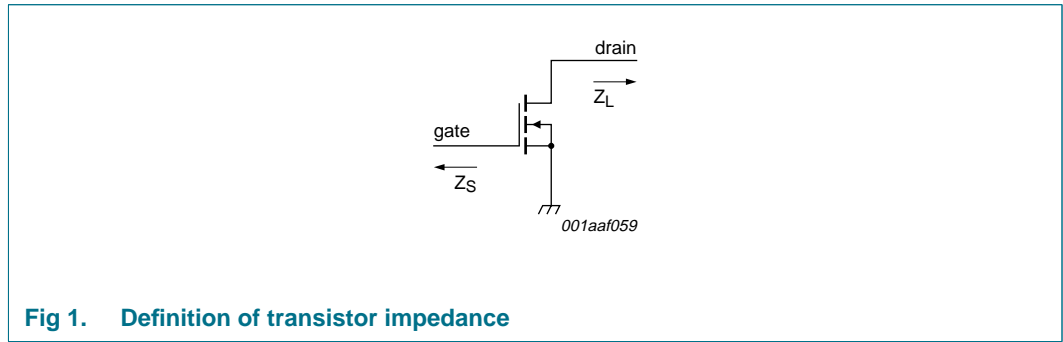
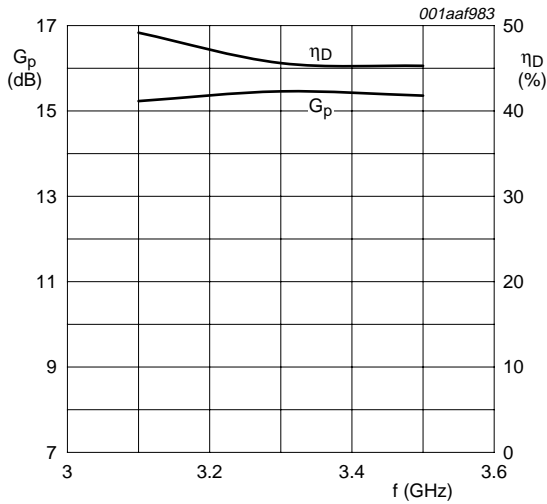


Fig 1. Definition of transistor impedance

7.2 Ruggedness in class-AB operation

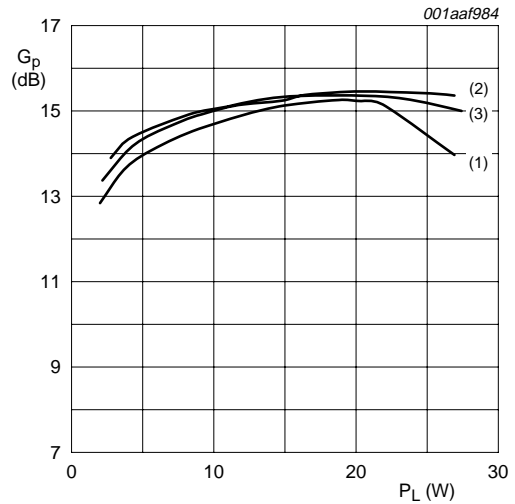
The BLS6G3135-20 and BLS6G3135S-20 are capable of withstanding a load mismatch corresponding to VSWR = 5 : 1 through all phases under the following conditions: V_{DS} = 32 V; I_{Dq} = 50 mA; P_L = 20 W; t_p = 300 μs; δ = 10 %.

7.3 Graphs



$V_{DS} = 32\text{ V}$; $I_{Dq} = 50\text{ mA}$; $t_p = 300\ \mu\text{s}$; $\delta = 10\%$;
 $P_L = 20\text{ W}$.

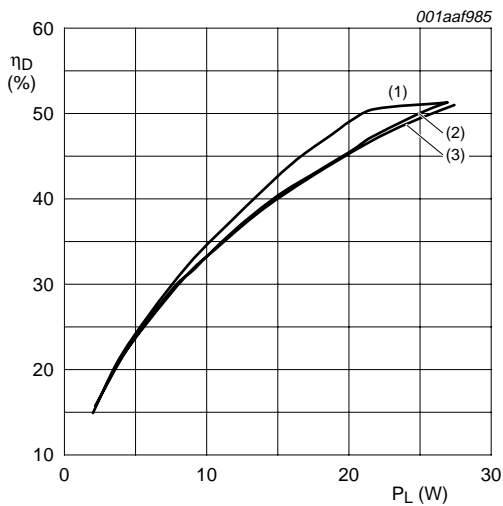
Fig 2. Power gain and drain efficiency as functions of frequency; typical values



$V_{DS} = 32\text{ V}$; $I_{Dq} = 50\text{ mA}$; $t_p = 300\ \mu\text{s}$; $\delta = 10\%$.

- (1) $f = 3.1\text{ GHz}$
- (2) $f = 3.3\text{ GHz}$
- (3) $f = 3.5\text{ GHz}$

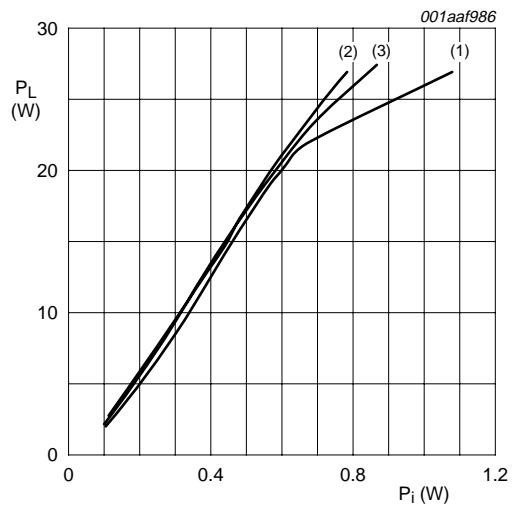
Fig 3. Power gain as a function of load power; typical values



$V_{DS} = 32\text{ V}$; $I_{Dq} = 50\text{ mA}$; $t_p = 300\ \mu\text{s}$; $\delta = 10\%$.

- (1) $f = 3.1\text{ GHz}$
- (2) $f = 3.3\text{ GHz}$
- (3) $f = 3.5\text{ GHz}$

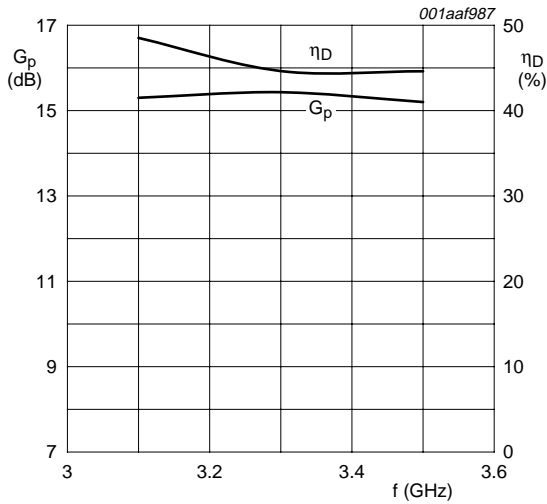
Fig 4. Efficiency as a function of load power; typical values



$V_{DS} = 32\text{ V}$; $I_{Dq} = 50\text{ mA}$; $t_p = 300\ \mu\text{s}$; $\delta = 10\%$.

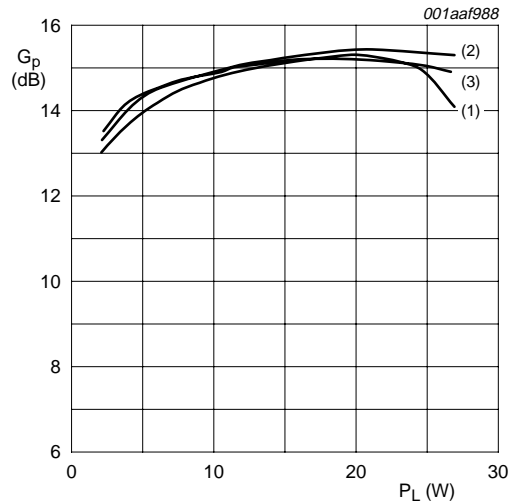
- (1) $f = 3.1\text{ GHz}$
- (2) $f = 3.3\text{ GHz}$
- (3) $f = 3.5\text{ GHz}$

Fig 5. Load power as a function of input power; typical values



$V_{DS} = 32\text{ V}$; $I_{Dq} = 100\text{ mA}$; $t_p = 50\text{ }\mu\text{s}$; $\delta = 20\text{ }\%$;
 $P_L = 20\text{ W}$.

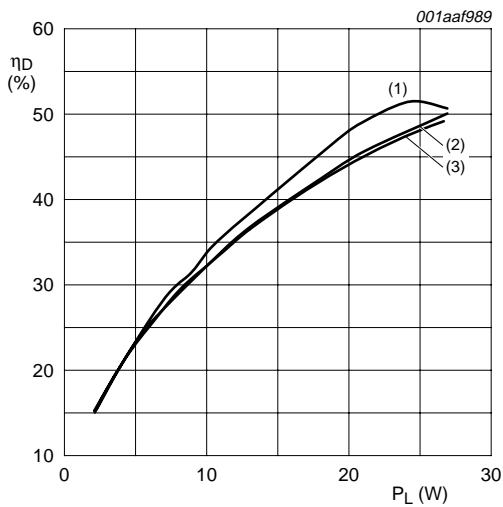
Fig 6. Power gain and drain efficiency as functions of frequency; typical values



$V_{DS} = 32\text{ V}$; $I_{Dq} = 50\text{ mA}$; $t_p = 100\text{ }\mu\text{s}$; $\delta = 20\text{ }\%$.

- (1) $f = 3.1\text{ GHz}$
- (2) $f = 3.3\text{ GHz}$
- (3) $f = 3.5\text{ GHz}$

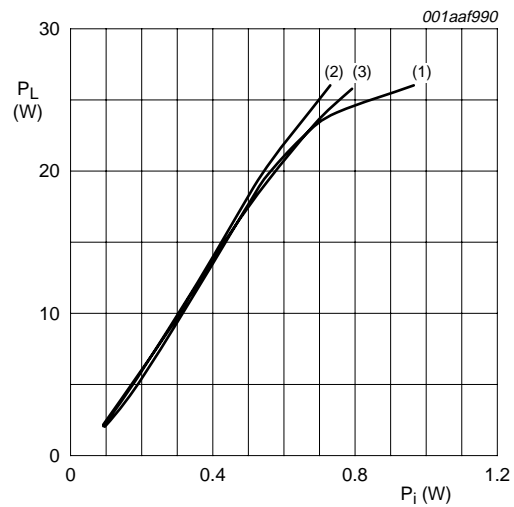
Fig 7. Power gain as a function of load power; typical values



$V_{DS} = 32\text{ V}$; $I_{Dq} = 50\text{ mA}$; $t_p = 100\text{ }\mu\text{s}$; $\delta = 20\text{ }\%$.

- (1) $f = 3.1\text{ GHz}$
- (2) $f = 3.3\text{ GHz}$
- (3) $f = 3.5\text{ GHz}$

Fig 8. Efficiency as a function of load power; typical values



$V_{DS} = 32\text{ V}$; $I_{Dq} = 50\text{ mA}$; $t_p = 100\text{ }\mu\text{s}$; $\delta = 20\text{ }\%$.

- (1) $f = 3.1\text{ GHz}$
- (2) $f = 3.3\text{ GHz}$
- (3) $f = 3.5\text{ GHz}$

Fig 9. Load power as a function of input power; typical values

8. Test information

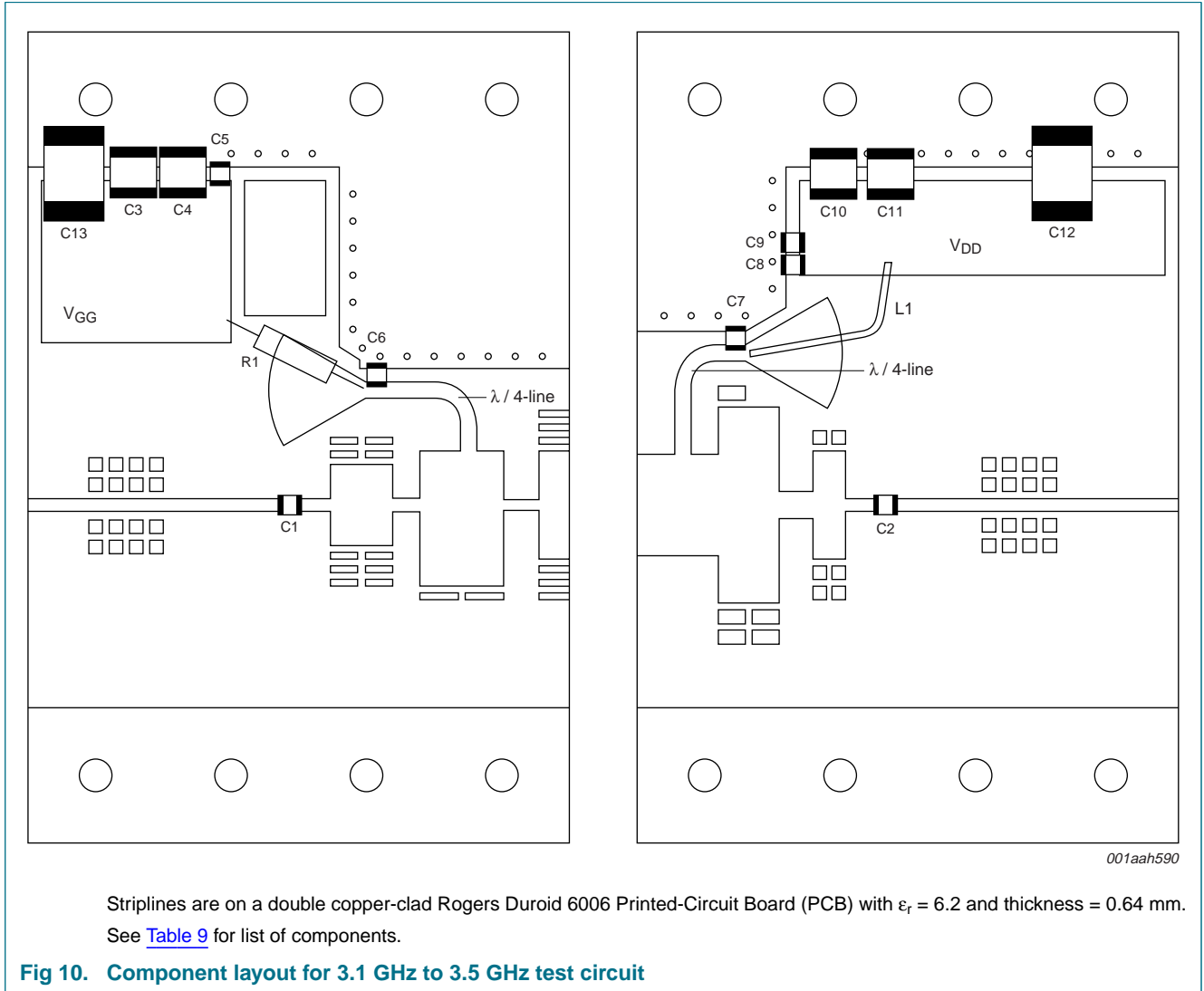


Table 9. List of components

See [Figure 10](#).

| Component | Description | Value | Remarks |
|----------------------------|-----------------------------------|------------------|---------|
| C1, C2, C5, C6, C7, C8, C9 | multilayer ceramic chip capacitor | 33 pF | [1] |
| C3, C4, C10, C11 | multilayer ceramic chip capacitor | 470 pF | [2] |
| C12 | electrolytic capacitor | 47 μ F; 63 V | |
| C13 | electrolytic capacitor | 10 μ F; 35 V | |
| L1 | copper wire | - | |
| R1 | resistor | 49.9 Ω | |

[1] American Technical Ceramics type 100A or capacitor of same quality.

[2] American Technical Ceramics type 100B or capacitor of same quality.

9. Package outline

Flanged ceramic package; 2 mounting holes; 2 leads

SOT608A

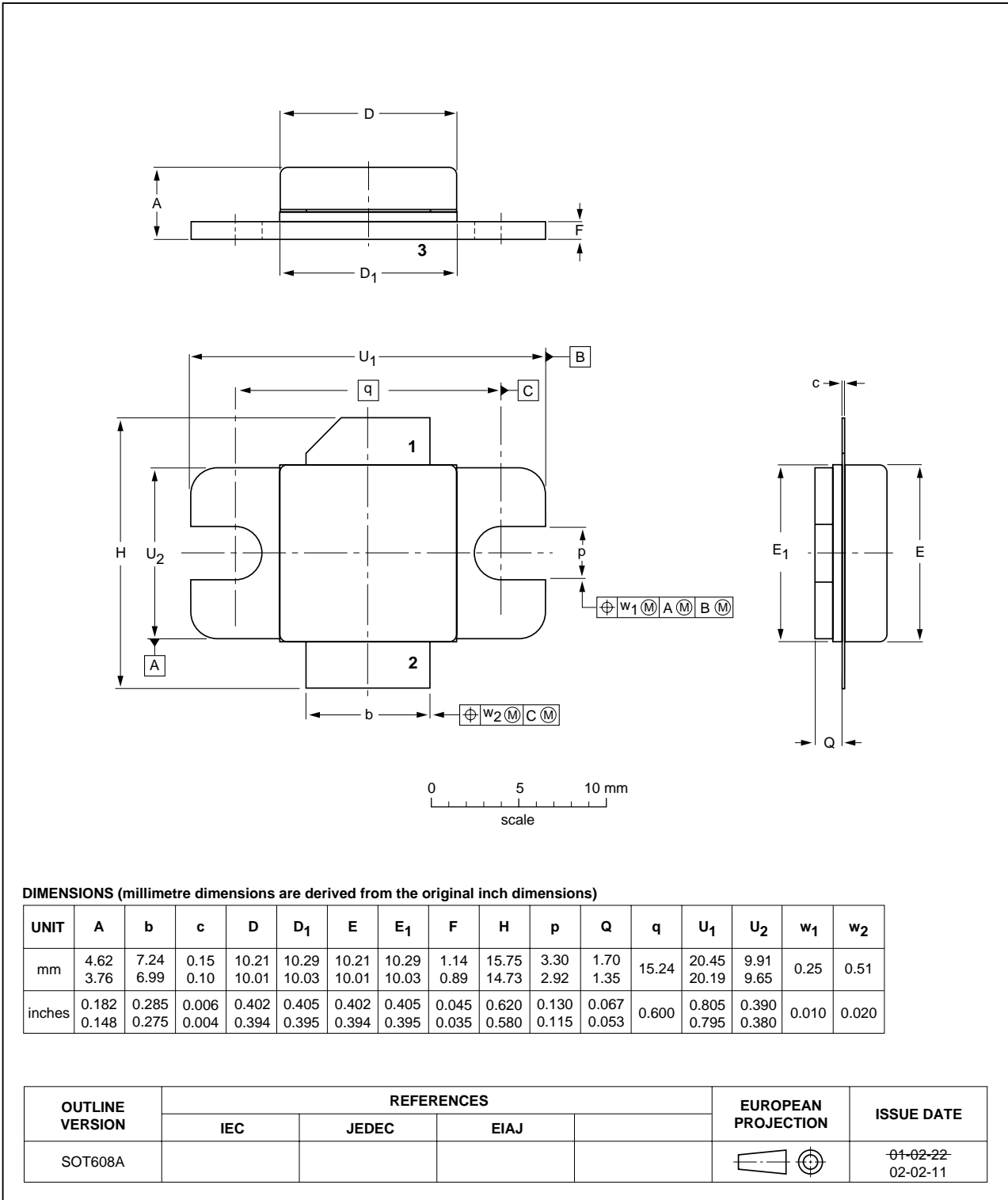


Fig 11. Package outline SOT608A

Ceramic earless flanged package; 2 leads

SOT608B

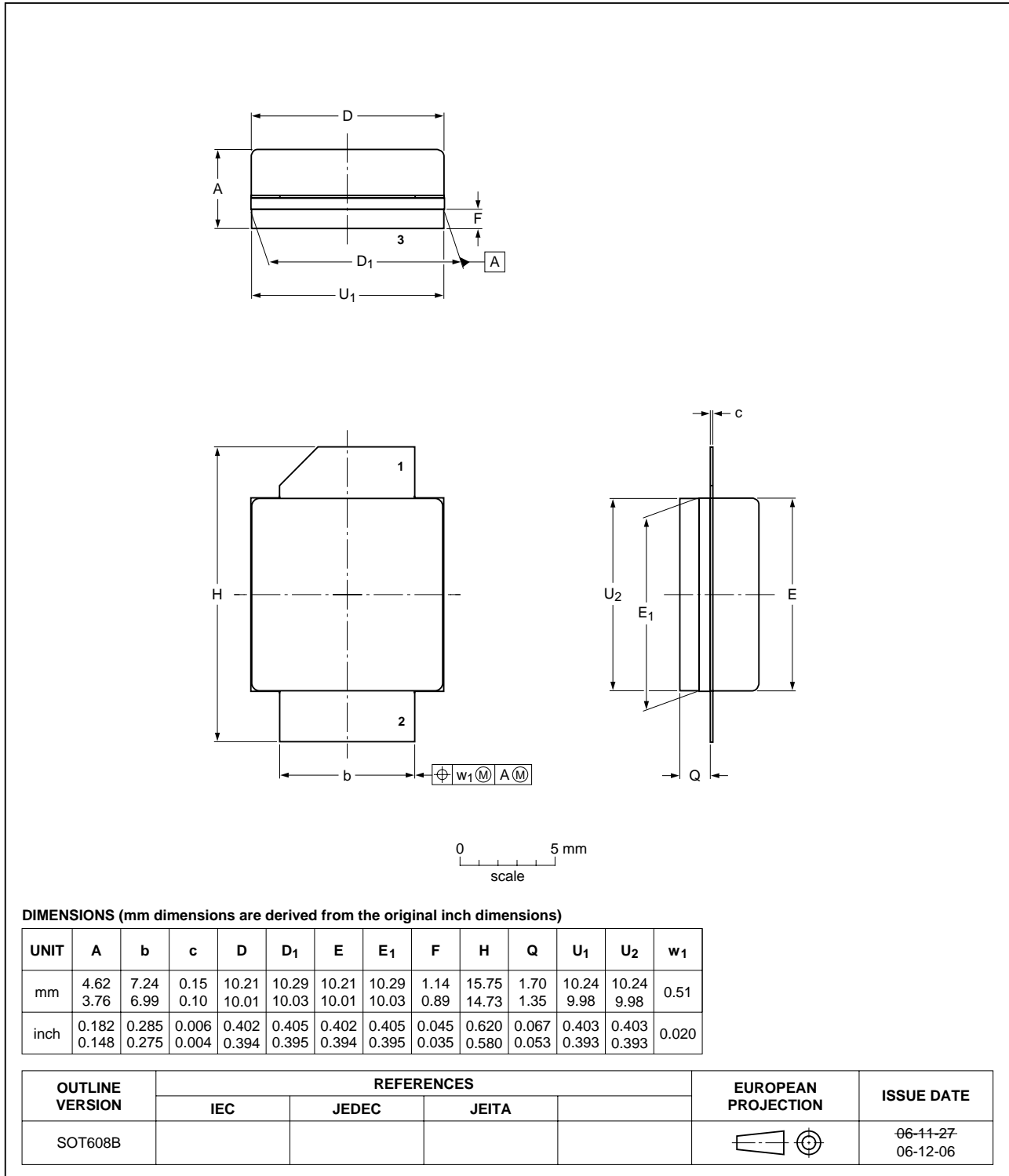


Fig 12. Package outline SOT608B

10. Abbreviations

Table 10. Abbreviations

| Acronym | Description |
|---------|--|
| LDMOS | Laterally Diffused Metal Oxide Semiconductor |
| RF | Radio Frequency |
| S-Band | Short wave Band |
| VSWR | Voltage Standing-Wave Ratio |

11. Revision history

Table 11. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|---------------------------|---|----------------------|---------------|---------------------------|
| BLS6G3135-20_6G3135S-20_3 | 20090303 | Product data sheet | - | BLS6G3135-20_6G3135S-20_2 |
| Modifications: | • Section 7.1 on page 4 : Impedance information added | | | |
| BLS6G3135-20_6G3135S-20_2 | 20081217 | Product data sheet | - | BLS6G3135-20_6G3135S-20_1 |
| BLS6G3135-20_6G3135S-20_1 | 20070307 | Objective data sheet | - | - |

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12.1 Data sheet status

| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
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| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
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[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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14. Contents

| | | |
|-----------|--|-----------|
| 1 | Product profile | 1 |
| 1.1 | General description | 1 |
| 1.2 | Features | 1 |
| 1.3 | Applications | 2 |
| 2 | Pinning information | 2 |
| 3 | Ordering information | 2 |
| 4 | Limiting values | 2 |
| 5 | Thermal characteristics | 3 |
| 6 | Characteristics | 3 |
| 7 | Application information | 3 |
| 7.1 | Impedance information | 4 |
| 7.2 | Ruggedness in class-AB operation | 4 |
| 7.3 | Graphs | 5 |
| 8 | Test information | 7 |
| 9 | Package outline | 8 |
| 10 | Abbreviations | 10 |
| 11 | Revision history | 10 |
| 12 | Legal information | 11 |
| 12.1 | Data sheet status | 11 |
| 12.2 | Definitions | 11 |
| 12.3 | Disclaimers | 11 |
| 12.4 | Trademarks | 11 |
| 13 | Contact information | 11 |
| 14 | Contents | 12 |

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